EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2350	716/4.CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/21 12:37
S74	100	(wafer with lot) and defect and (layer with model)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 08:53
S75	83	(wafer with lot) and defect and (layer with model) and @ad<"20040202"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/16 10:48
S76	8	("5444632" | "5940787" | "6088626" | "6105520" | "6128588" | "6260427" | "6415196" | "6456894").PN. OR ("6978187").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/03/16 08:36
S77	19	("3751647" | "5105362" | "5642296" | "5661669" | "5761481" | "5866437" | "5910011" | "5966312" | "6028994" | "6041270" | "6470230").PN. OR ("6622059"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/03/16 08:42
S78	90	("3151237" | "3222504" | "3260838" | "3515860" | "3598604" | "3615464" | "3615466" | "3618199").PN. OR ("3751647").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/03/16 10:43
S80	5	("4514436" | "5369604" | "6314379").PN. OR ("6421574"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/03/16 10:48
S83	2	"6449749".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/17 08:47
S84	2143	716/4.CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/21 12:37

EAST Search History

S85	1478	700/121.CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 09:40
S86	1327	700/121.CCLS. and @ad<"20040202"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/17 08:49
S87	20	(716/4.CCLS. or 700/121.CCLS.) and (defect with model) and lot and @ad<"20040202"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/03/17 08:50
S88	21	(partial$2 with completed) and defect and (layer with model)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:34
S89	19	("3751647" | "5105362" | "5642296" | "5661669" | "5761481" | "5866437" | "5910011" | "5966312" | "6028994" | "6041270" | "6470230").PN. OR ("6622059"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/11 16:09
S91	5	("5933345" | "6298470").PN. OR ("6725121").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/11 16:12
S92	25	(partial$2 with completed) and defect and (production with lot)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/11 16:20
S93	63	steffan-paul-j.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/11 16:22
S94	3	"6901564".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 07:53

S95	40	("3751647" | "4795964" | "4835466" | "4939681" | "5067101" | "5068547" | "5070469" | "5286656" | "5301118" | "5438527" | "5486786" | "5502643" | "5625268" | "5627083" | "5629877" | "5655110" | "5703381" | "5767542" | "5773315" | "5778202" | "5790479" | "5798649" | "5822258" | "5852581" | "5867033" | "5903012" | "5966527" | "5982929" | "6005829" | "6063132" | "6066179" | "6072804" | "6075417" | "6075418" | "6118137" | "6124143" | "6134191" | "6184048" | "6289257" | "6393602").PN. OR ("6901564").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/12 07:54
S96	4	(wafer with lot) and defect and (layer near2 model) and (product$3 or manufactur$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:25
S97	0	((wafer with lot) and defect and (layer near2 model) and (product$3 or manufactur$3)).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:25
S98	0	(defect and (completed adj3 dies) and production and model).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:27
S99	18	(disposition adj3 wafer) and production and model and defect	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:32
S100	0	((disposition adj3 wafer) and production and model and defect).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:33
S101	0	((partially adj2 completed adj2 dies) and production and model and defect).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:33

EAST Search History

S102	13	(one adj2 layer adj2 model).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:35
S103	1	(wafer with lot) and defect and (layer with model) and (intermediate with process$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:44
S104	83	(wafer with lot) and defect and (layer with model) and @ad<"20040202"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 08:47
S105	0	((wafer with lot) and defect and (layer with model)).CLM.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/12 09:00
S106	1116	wafer and feed near3 forward	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 08:54
S107	768	wafer and feed near3 forward and layer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 08:54
S108	367	wafer and feed near3 forward and layer and yield	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 10:11
S109	22	wafer and feed near3 forward and layer near3 model and yield	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 09:20
S110	5	wafer and feed near3 forward and layer near3 model and yield and defect	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 09:20
S111	24	700/121.CCLS. and defect and yield and wafer and lot and intermediate	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/13 09:41

| S11 2 | 63 | wafer and feed near3 forward and layer and yield and ("716"/$.CCLS. or 700/121.CCLS.) and @ad<"20040202" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2006/07/13 10:12 |